



● **Features**

$V_{DS} = 20V, I_D = 50A$

$R_{DS(ON)} @ V_{GS} = 4.5V, TYP 3.8m\Omega$

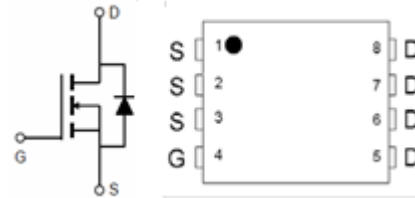
$R_{DS(ON)} @ V_{GS} = 2.5V, TYP 4.3m\Omega$

$R_{DS(ON)} @ V_{GS} = 1.8V, TYP 5.7m\Omega$

● **General Description**

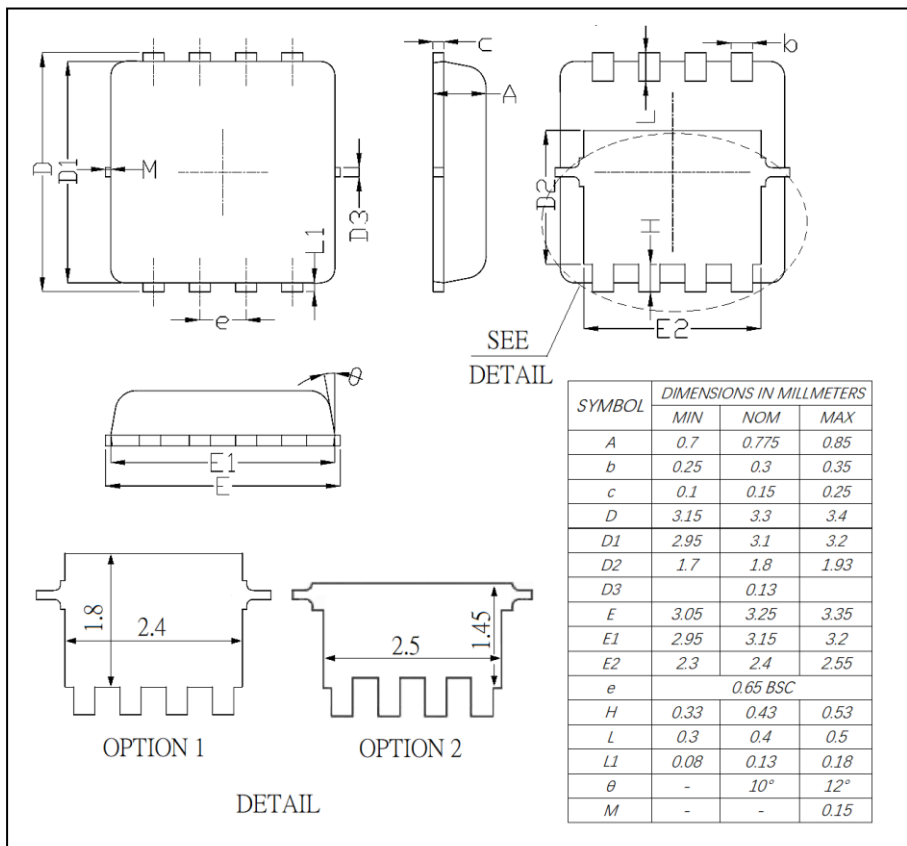
LT4422FL uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

● **Pin Configurations**



PDFN3*3

● **Package Information**



● **Absolute Maximum Ratings @ $T_A=25^\circ C$ unless otherwise noted**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DSS}	20	V
Gate-Source Voltage	V_{GSS}	± 12	V

Drain Current (Continuous) *AC	T _A =25°C	I _D	50	A
	T _A =100°C		40	
Drain Current (Pulse) *B		I _{DM}	200	A
Power Dissipation	T _A =25°C	P _D	35	W
Thermal Resistance Junction to Case		R _{θJC}	3.5	°C/W
Thermal Resistance Junction to Ambient		R _{θJA}	78	°C/W
Operating Temperature/ Storage Temperature		T _J /T _{STG}	-55~150	°C

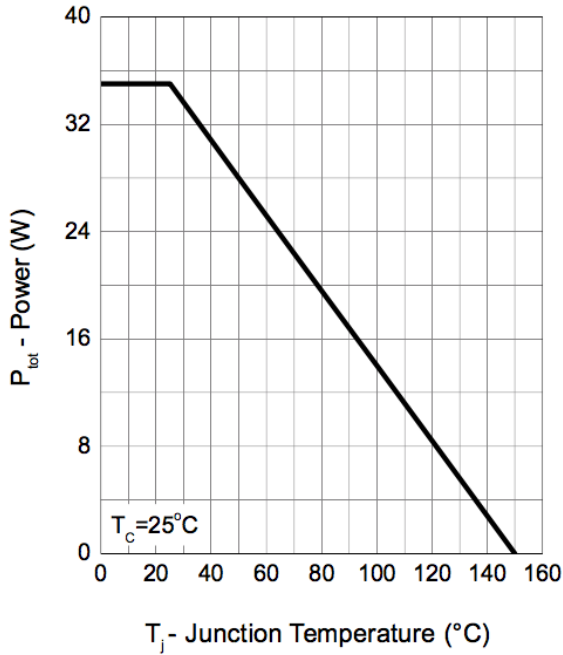
● **Electrical Characteristics** @T_A=25°C unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250 μA	20	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16V, V _{GS} = 0V	--	--	1	μA
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _{DS} = 250 μA	0.5	0.7	1	V
Gate Leakage Current	I _{GSS}	V _{GS} = ±12V, V _{DS} = 0V	--	--	±100	nA
Drain-Source On-state Resistance	R _{DS(on)}	V _{GS} = 4.5V, I _D = 13.5A	--	3.8	4.5	mΩ
	R _{DS(on)}	V _{GS} = 2.5V, I _D = 10A	--	4.3	5	mΩ
	R _{DS(on)}	V _{GS} = 1.8V, I _D = 2A	--	5.7	7	mΩ
Forward Transconductance	g _{FS}	V _{DS} = 5V, I _D = 10A	--	34	--	S
Diode Forward Voltage	V _{SD}	I _{SD} = 2A, V _{GS} = 0V	--	--	1.1	V
Diode Forward Current	I _S	TC=25°C	--	--	25	A
Switching						
Total Gate Charge	Q _g	V _{DS} =10V, I _D =13.5A, V _{GS} =4.5V	--	35	--	nC
Gate-Source Charge	Q _{gs}		--	4.7	--	nC
Gate-Drain Charge	Q _{gd}		--	11.5	--	nC
Turn-on Delay Time	t _{d(on)}	V _{DD} =10V, V _{GS} =10V, R _{GEN} =6Ω, I _D =1A	--	14	--	ns
Turn-on Rise Time	t _r		--	14.5	--	ns
Turn-off Delay Time	t _{d(off)}		--	130	--	ns
Turn-Off Fall Time	t _f		--	70	--	ns
Dynamic						
Input Capacitance	C _{iss}	V _{DS} =10V, V _{GS} =0V, f=1.0MHz	--	1809	--	pF
Output Capacitance	C _{oss}		--	585	--	pF
Reverse Transfer Capacitance	C _{rss}		--	386	--	pF

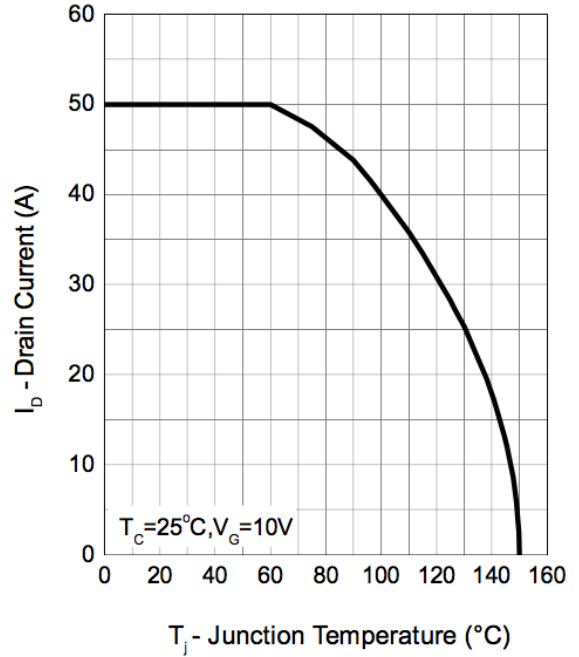
A: The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. B: Repetitive rating, pulse width limited by junction temperature. C: The current rating is based on the t_s ≤ 10s junction to ambient thermal resistance rating.

- Typical Performance Characteristics

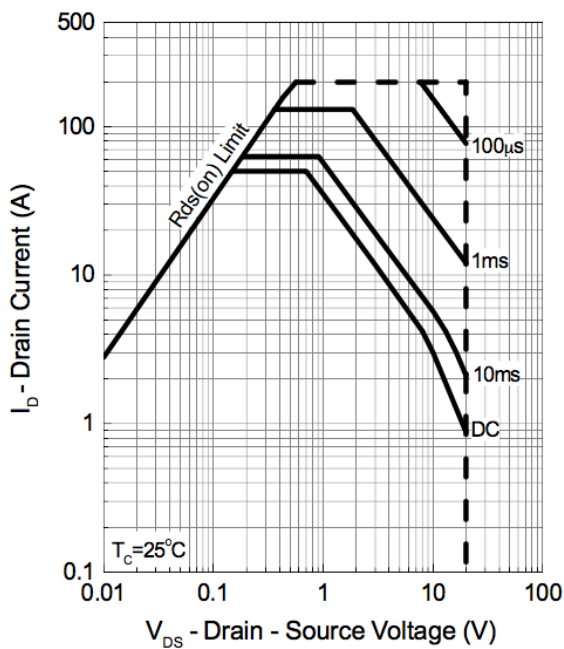
Power Dissipation



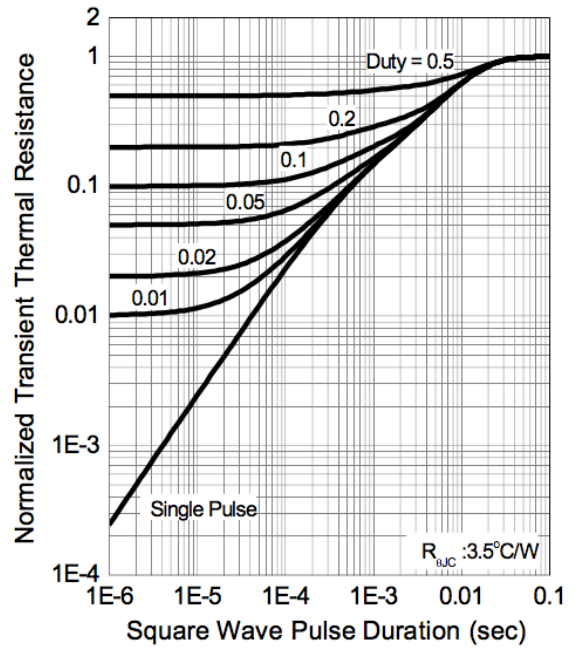
Drain Current



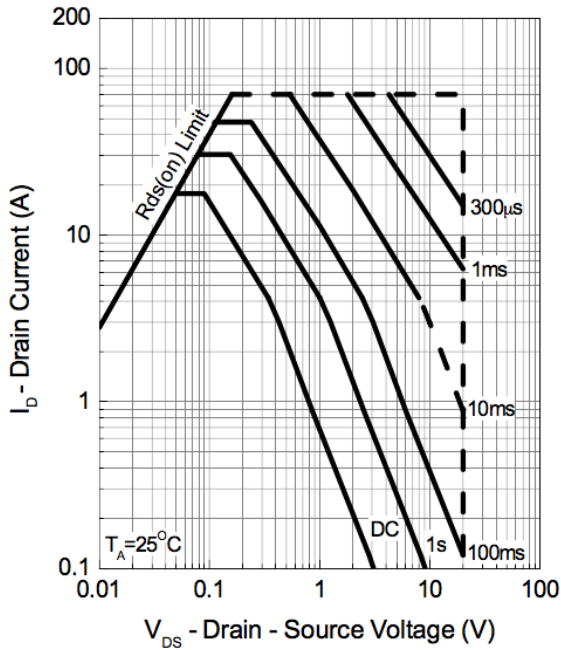
Safe Operation Area



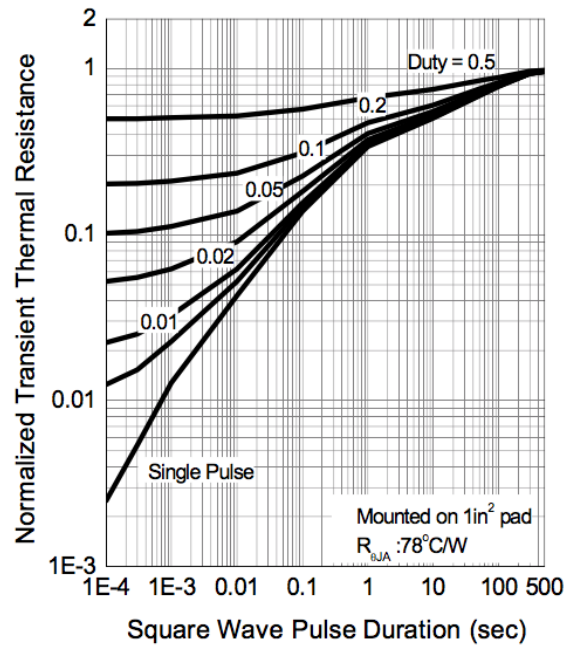
Thermal Transient Impedance



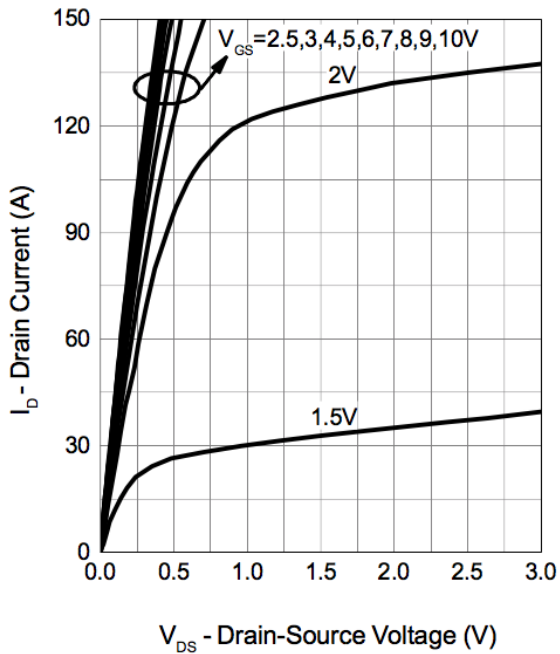
Safe Operation Area



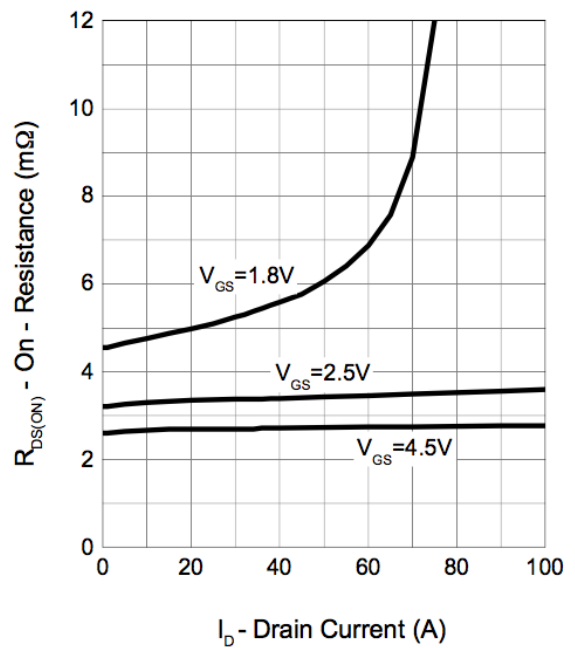
Thermal Transient Impedance



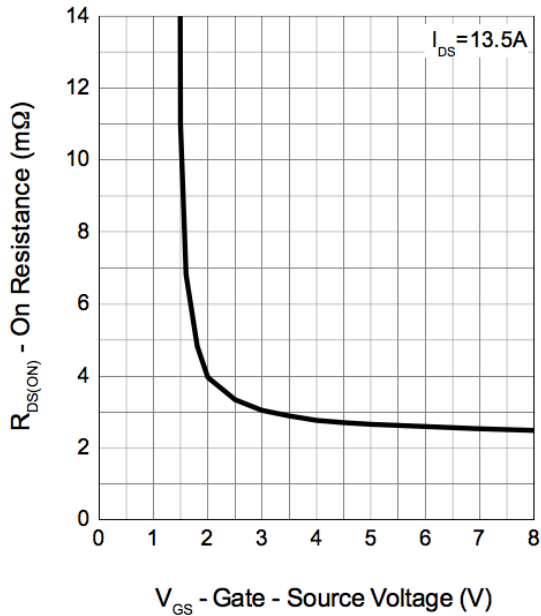
Output Characteristics



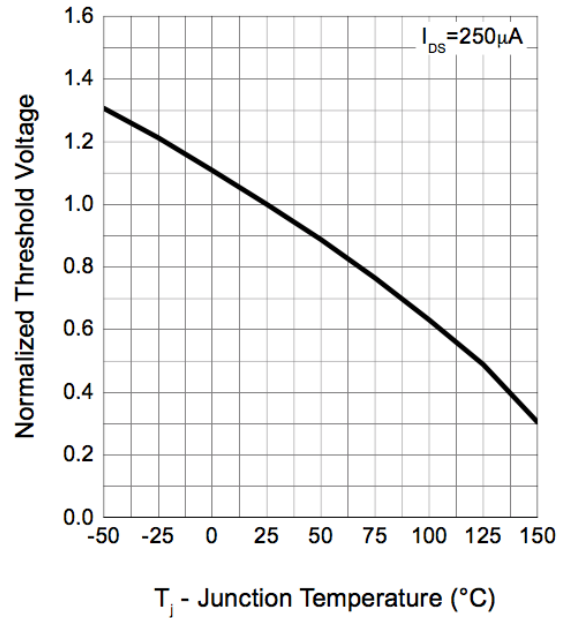
Drain-Source On Resistance



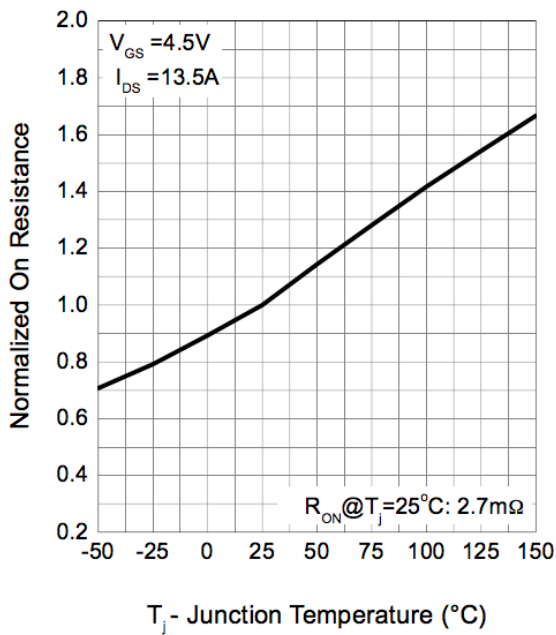
Gate-Source On Resistance



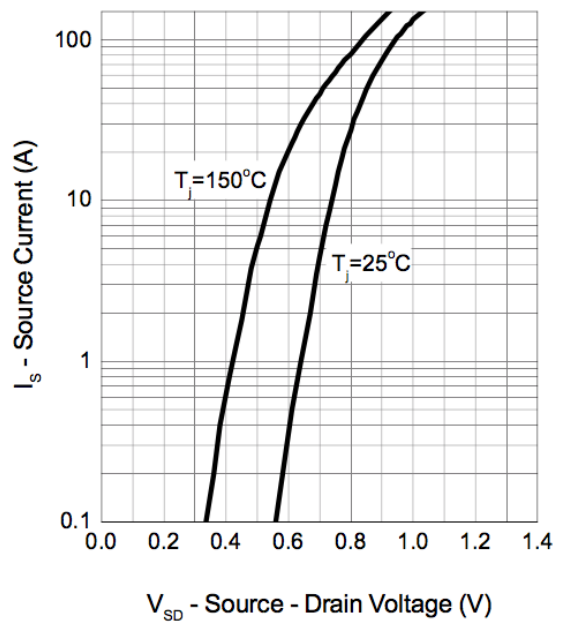
Gate Threshold Voltage



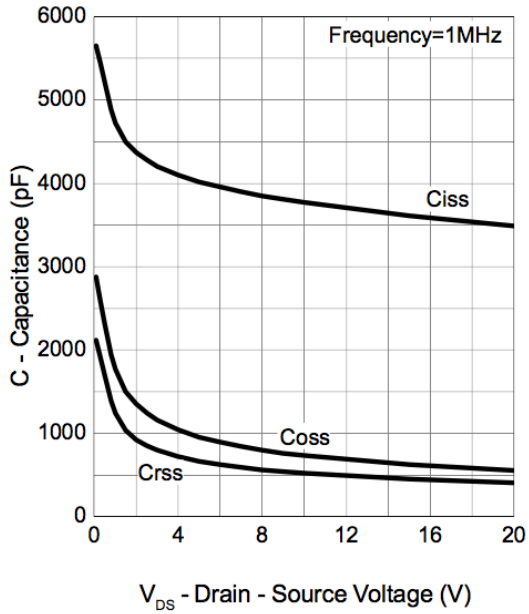
Drain-Source On Resistance



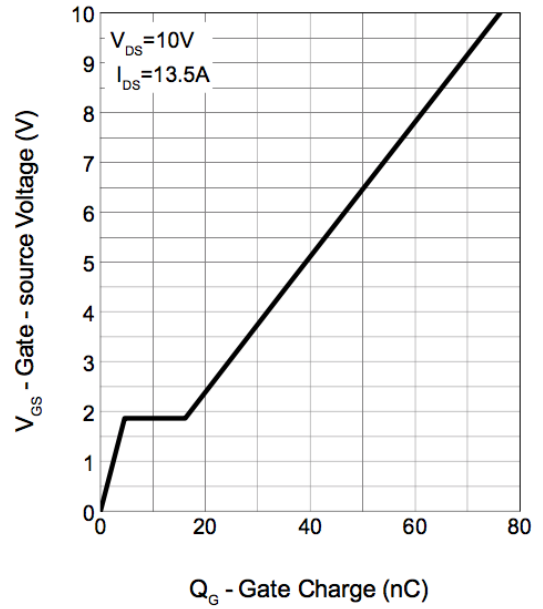
Source-Drain Diode Forward



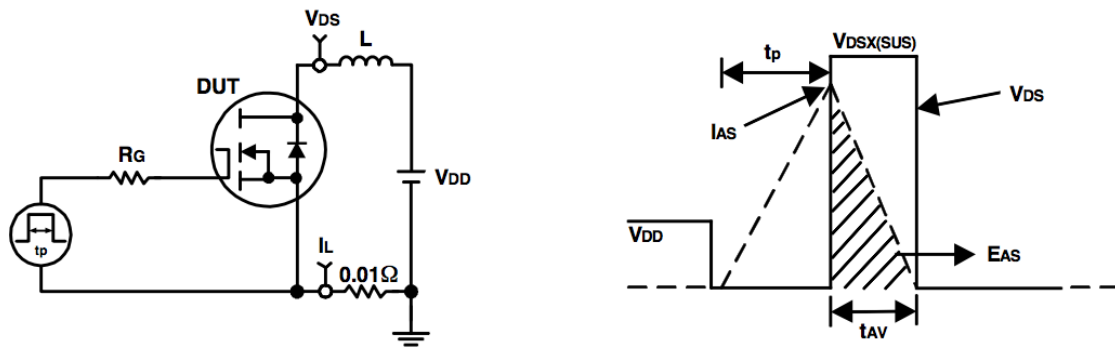
Capacitance



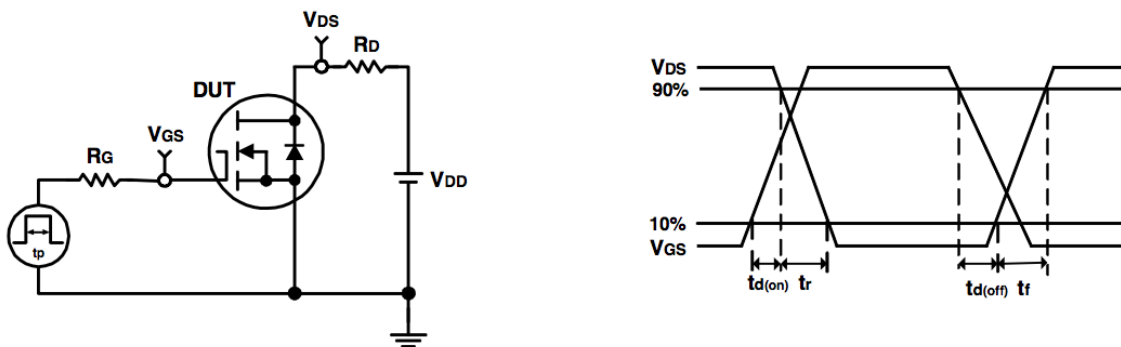
Gate Charge



Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	245°C±5°C	5sec±1sec
Pb-Free device	260°C+0/-5°C	5sec±1sec



This integrated circuit can be damaged by ESD. UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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